

<b>Search Notes</b> 				Application/Control No.	Applicant(s)/Patent under Reexamination	
				10/662,418	CHISHOLM ET AL.	
				Examiner	Art Unit	
				Tae H. Yoon	1714	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
526	222	9-2-05	ay	EAST	9-1-05	ay
	321			Inventor Search	9-2-05	ay
	329.7					
A1D		1-19-06	ay			
A1D		7-18-06	ay			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			